Datasheet

10 Gbps 980nm VCSEL



DESCRIPTION

Inneos' 980nm 10 Gbps VCSEL was designed for extended temperature operating environments from -40°C to +125°C to meet the needs of automotive and industrial applications, where low operating currents and extended lifetimes are critical parameters. The device allows for wirebond assemblies to support a variety of packaging options. The Inneos 980nm VCSEL maintains superior performance in wide range of operating environments.



FEATURES

- Operating temperature from -40°C to +125°C
- Top-emitting
- Single channel

APPLICATIONS

- Wide-Temperature Transceivers
- Transmitter Optical Sub-Assemblies

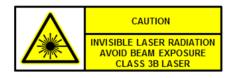
ORDERING INFORMATION

PART NUMBER	DESCRIPTION
V980-10GXA-1TGA	10 Gbps 980nm VCSEL, Bare Die, -40°C to 125°C, Gel-Pak



ATTENTION: OBSERVE PRECAUTIONS FOR HANDLING ELECTROSTATIC DEVICES

Stress conditions greater than those listed under "Absolute Maximum Ratings" may permanently damage the device. Operation of devices beyond these stress conditions for extended periods may effect device reliability.



ABSOLUTE MAXIMUM RATINGS

	PARAMETER	SYMBOL	MIN	MAX	UNITS
P	Storage Temperature Range	Ts	-65	135	°C
	Operating Temperature Range	To	-40	125	°C
	Reverse Voltage	V_R		8	V
6	Continuous Forward Current	I _F		10	mA
ě	ESD Protection (HBM)			200	V

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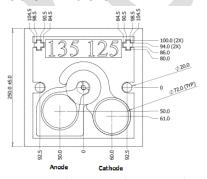


OPTICAL/ELECTRICAL SPECIFICATIONS

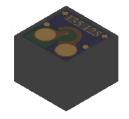
PARAMETER	CONDITIONS	SYMBOL	UNITS	MIN	TYPICAL	MAX
Emission Wavelength	T _o =30°C @ 3mA	λ_c	nm	965	-	990
Variation of Wavelength with Temperature	-	$\frac{\Delta \lambda}{\Delta T}$	nm/°C	-	0.06	0.07
Spectral Width ^a	T₀=30°C @ 3mA	σ_{λ}	nm	-	0.4	-
	T _o =-40°C	I_{th}	mA	-	0.5	0.7
Threshold Current ^b	T _o =30°C			-	0.7	-
	T₀=125°C			-	1.6	2.0
Average Operating Current	T _o =30°C	I_{avg}	mA	-	3	1
Operating Voltage	T _o =-40°C @ P _o =1mW	V_o	V	-	-	3.15
Operating voitage	T₀=125°C @ P₀=1mW			-	ı	2.0
Optical Output Power	T₀=-40°C @ 2.2mA, 125°C @ 4.3mA	P_{o}	mW	1.0	-	-
	T₀=30°C, @ 3mA			-	1.6	ı
Small Signal Bandwidth ^c	T₀=30°C @ 3mA	f_{3dB}	GHz	7.75	ı	-
Beam Divergence Half Angle (1/e²) ^d	T _o =30°C @ 3mA	$ heta_{1/2}$	deg	-	16	-
Slope Efficiency ^e	T _o =-40°C	T _o =-40°C <i>SE</i>		-	0.75	-
Slope Linciency	T _o =125°C	SE	$mW/_{mA}$	-	0.5	-
Differential Resistance f	T _o =125°C @ 6mA	R_{diff}	Ω	-	89	-

MECHANICAL OUTLINE

Dimensions are in microns.



TES UNLESS OTHERWISE SPEC FIED:
INTERPRET DRAWING IN ACCORDANCE WITH ASME Y14.5-2009.
SUBSTIRATE MATERIAL: GAS, TOTAL GOLD.
WREBOND PAD MATERIAL: 1 mm GOLD.
WREBOND PAD LOTAL DE FLILLY CONTAINED WITHIN BOND PAD O PENINGS.



ELECTROSTATIC-DISCHARGE SENSITIVE DEVICE: FOLLOW ESD PROTECTIVE HANDLING PROCEDURES IN ACCORDANCE WITH ANSI/ESD S20.20-2014.

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PARAMETER CALCULATION METHODS USED

a. Spectral width is calculated based on FOTP-127 where the spectral level of the measured spectra below 20dB from maximum value are made zero and RMS spectral width is calculated based on formula

$$\Delta \lambda_{RMS} = \sqrt{\frac{\sum_{i=1}^{N} P_{i} \lambda_{i}^{2}}{\sum_{i=1}^{N} P_{i}}} - (\frac{\sum_{i=1}^{N} P_{i} \lambda_{i}}{\sum_{i=1}^{N} P_{i}})^{2}$$

where ' λ_i ' is the wavelength and ' P_i ' is the optical power level of the i_{th} point in the spectra.

- b. The threshold current is derived by a linear fit method using 10% and 20% of peak optical power points. Threshold current is the point at which the optical power is zero using the linear fit.
- c. The small signal bandwidth is obtained from optical response measurements at set current and reading the cut off frequency at which the power level is 3dB down from the power level at DC.
- d. Beam divergence half-angle is derived from measurement of optical power in far-field at various angles. The half-angle is the angular deviation from center where the power reduces by '1/e'.
- e. The slope efficiency is derived by linear fit method using 10% and 20% of peak optical power points. Slope efficiency is the slope of the lineal fit of optical power and drive current.
- f. Differential resistance at point 'i' of the measured LIV is calculated based on formula,

$$R_{diff} = \frac{V_i - V_{i-1}}{I_i - I_{i-1}}$$

where ' V_i ', ' V_{i-1} ' are the measured voltages at set currents ' I_i ' and ' I_{i-1} ' respectively.